

1200V 42A N-Channel SIC Power MOSFET

Features:

- High blocking voltage with low on-resistance
- High speed switching with low capacitance
- High operating junction temperature capability
- Very fast and robust intrinsic body diode
- Kelvin gate input easing driver circuit design

TO-247-4L



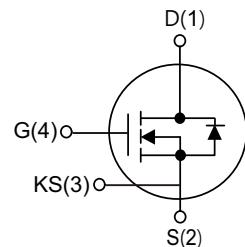
Mechanical Data:

- Case: TO-247-4L Package

Applications:

- Motor drivers
- Solar inverters
- Automotive DC/DC converters
- Automotive compressor inverters
- Switch mode power supplies

Block Diagram



Product Summary			
V _{DS}	R _{D(on)} (mΩ)Typ	I _D (A)	Q _g (Typ)
1200V	80 @ 20V 10A	41	66nc

Table1 Absolute Maximum Ratings (T_c=25°C, unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	1200	V
Gate-Source Voltage (Max)	V _{GS(max)}	-10/+25	V
Recommend Gate-Source Voltage	V _{GSop}	-5/+20	V
Continuous Drain Current T _c =25°C	I _D	41	A
T _c =100°C		28	
Pulsed Drain Current (Note 1)	I _{DM}	80	A
Power Dissipation T _c =25°C	P _D	208	W
Operating Junction and Storage Temperature	T _J /T _{STG}	-55 ~ +150	°C

Table 2.Thermal Characteristics

Parameter	Symbol	KWSC80N120P	Unit
Thermal resistance Junction to Case	R _{θJC}	0.72	°C/W
Thermal resistance Junction to Ambient	R _{θJA}	40	°C/W

Table 3. Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=100\mu\text{A}$	1200	-	-	V
Drain-Source Leakage Current	I_{DSS}	$\text{V}_{\text{DS}}=1200\text{V}, \text{V}_{\text{GS}}=0\text{V}$	-	1	100	μA
Gate- Source Leakage Current	Forward	I_{GSS}	$\text{V}_{\text{GS}}=20\text{V}, \text{V}_{\text{DS}}=0\text{V}$	-	-	250 nA
	Reverse		$\text{V}_{\text{GS}}=-5\text{V}, \text{V}_{\text{DS}}=0\text{V}$	-	-	-250 nA
On Characteristics						
Gate Threshold Voltage	$\text{V}_{\text{GS(TH)}}$	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=5\text{mA}$	1.8	3.0	5.0	V
Static Drain-Source On-State Resistance	$\text{R}_{\text{DS(ON)}}$	$\text{V}_{\text{GS}}=20\text{V}, \text{I}_D=20\text{A}, \text{T}_J=25^\circ\text{C}$	-	80	100	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=20\text{V}, \text{I}_D=20\text{A}, \text{T}_J=175^\circ\text{C}$	-	130	-	
Gate Resistance	R_G	$f=1\text{MHz}$	-	2.0	-	Ω
Dynamic Characteristics						
Input Capacitance	C_{iss}	$\text{V}_{\text{DS}}=1000\text{V}, \text{V}_{\text{GS}}=0\text{V}, f=1\text{MHz}, V_{\text{AC}}=25\text{mV}$	-	1374	-	pF
Output Capacitance	C_{oss}		-	63	-	pF
Reverse Transfer Capacitance	C_{rss}		-	3.5	-	pF
Total switching energy	E_{TOT}	$\text{V}_{\text{DS}}=800\text{V}, \text{I}_D=20\text{A}$ $\text{V}_{\text{GS}}=-4/+20\text{V}, \text{R}_G=5.0\Omega, L=276\text{nH}, \text{T}_J=25^\circ\text{C}$	-	218	-	μJ
Turn-on switching energy	E_{ON}		-	73	-	μJ
Turn-off switching energy	E_{OFF}		-	145	-	μJ
Turn-On Delay Time	$\text{td}(\text{on})$		-	8.2	-	ns
Turn-On Rise Time	t_R		-	10.8	-	ns
Turn-Off Delay Time	$\text{td}(\text{off})$		-	16.7	-	ns
Turn-Off Fall Time	t_f		-	10.5	-	ns
Total Gate Charge	Q_G	$\text{V}_{\text{DD}}=800\text{V}, \text{I}_D=20\text{A}, \text{V}_{\text{GS}}=-5\text{to}20\text{V}$	-	66	-	nC
Gate-Source Charge	Q_{GS}		-	15	-	nC
Gate-Drain Charge	Q_{GD}		-	30	-	nC
Drain-Source Diode Characteristics and Maximum Ratings (Note 2)						
Drain-Source Diode Forward Voltage	V_{SD}	$\text{V}_{\text{GS}}=-4\text{V}, \text{I}_S=10\text{A}$	-	3.7	-	V
Reverse Recovery Time	trr	$\text{V}_{\text{GS}}=-4\text{V}, \text{VR}=800\text{V}, \text{I}_{\text{SD}}=20\text{A}, \text{dI}/\text{dt}=2800\text{A}/\mu\text{s}$	-	29.3	-	ns
Recovered charge	Q_{rr}		-	156.5	-	nC
Peak reverse recovery current	I_{rrm}		-	9.5	-	A

Notes: 1 Repetitive Rating Pulse width limited by maximum junction temperature

2 Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$

Typical Characteristics Diagrams

Figure 1. Output characteristics at $T_j=25^\circ\text{C}$

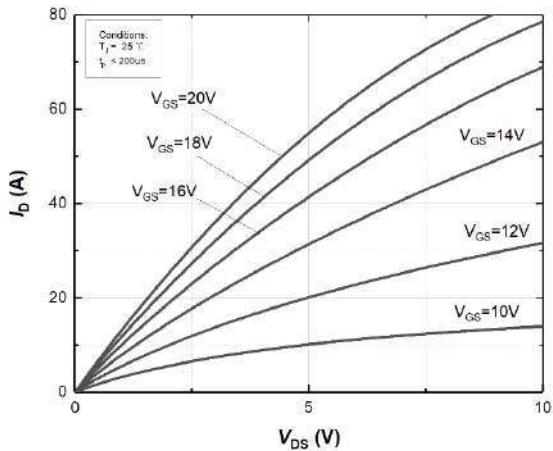


Figure 2. Output characteristics at $T_j=175^\circ\text{C}$

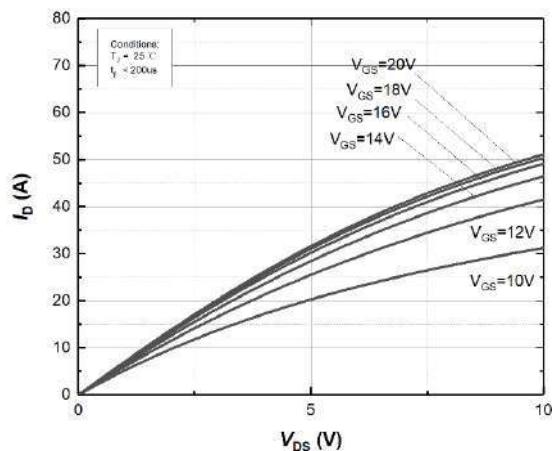


Figure 3. Normalized On-Resistance vs. Temperature

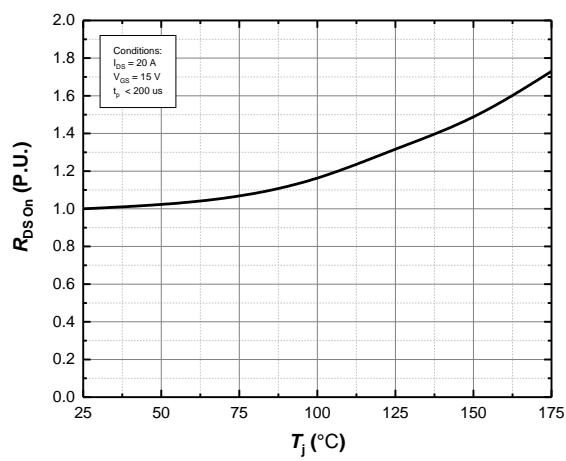


Figure 4. On-Resistance vs. Drain current for Various Temperature

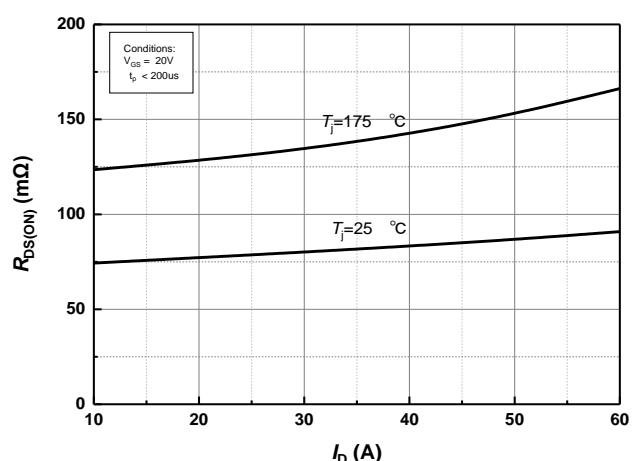


Figure 5. On-Resistance vs. Temperature for Various Gate Voltage

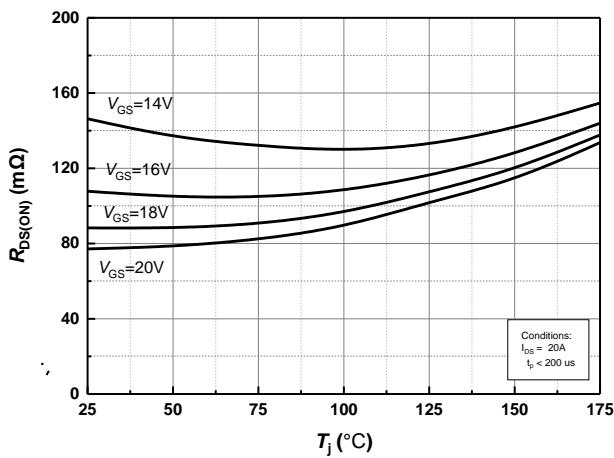
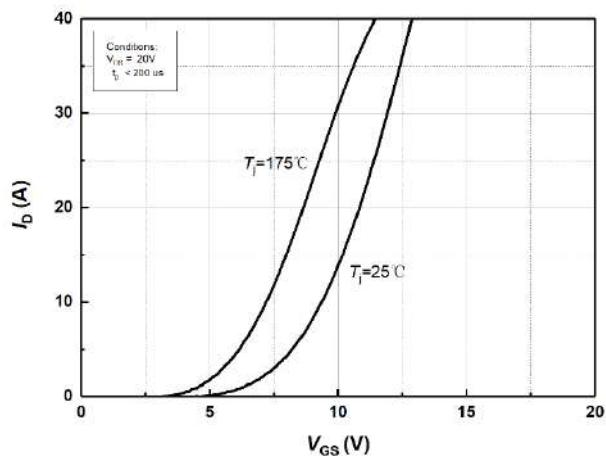


Figure 6. Transfer Characteristics for Various Junction Temperatures



Typical Characteristics Diagrams

Figure 7. Body Diode Characteristics at $T_J=25^\circ\text{C}$

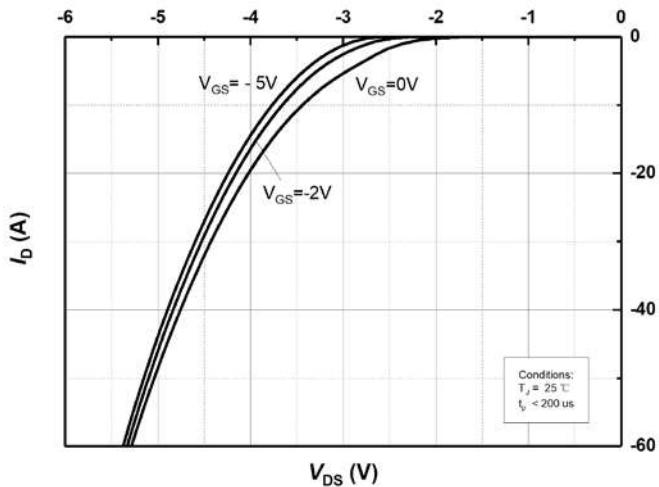


Figure 8. Body Diode Characteristics at $T_J=175^\circ\text{C}$

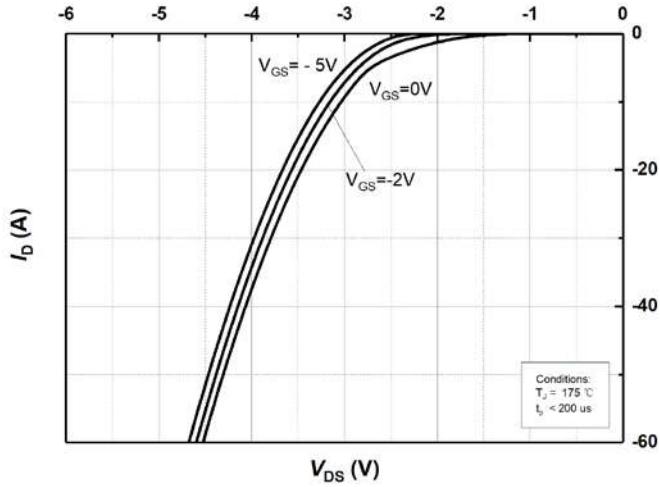


Figure 9. Threshold Voltage vs. Temperature

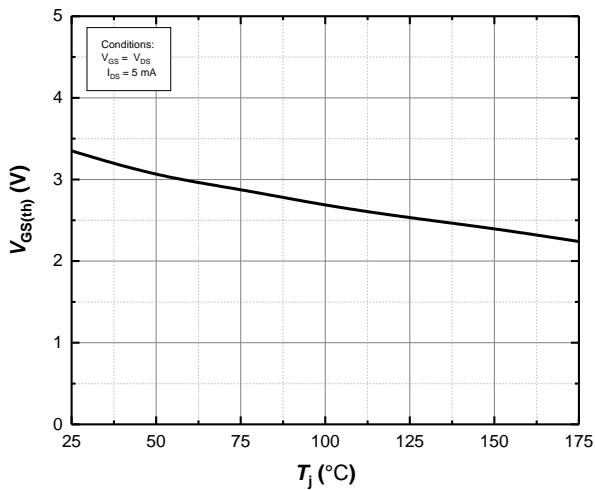


Figure 10 Gate Charge Characteristics

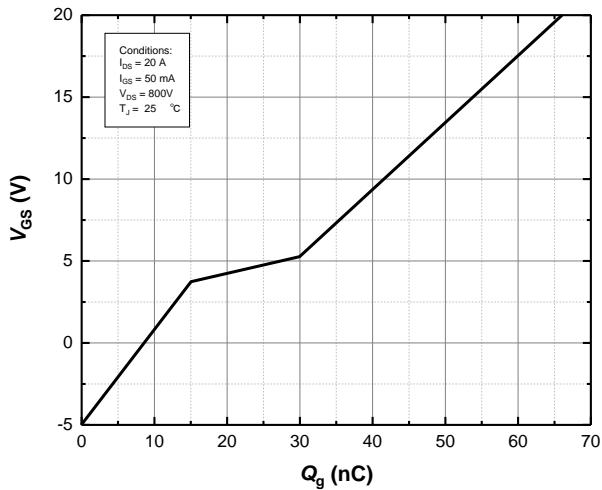


Figure 11. 3rd Quadrant Characteristic at $T_J=25^\circ\text{C}$

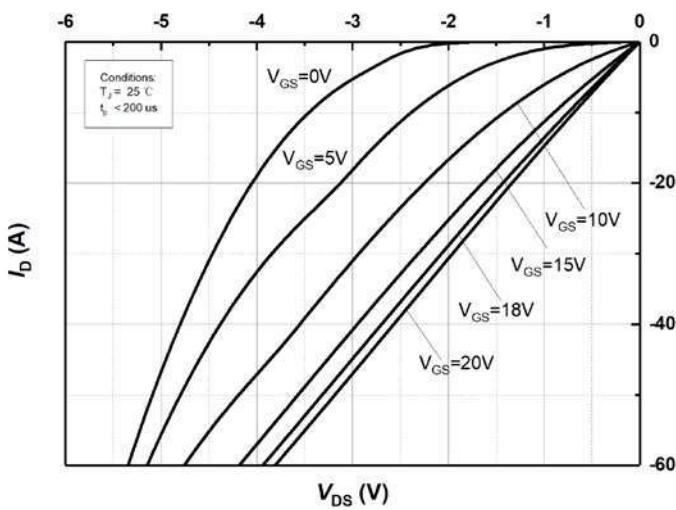
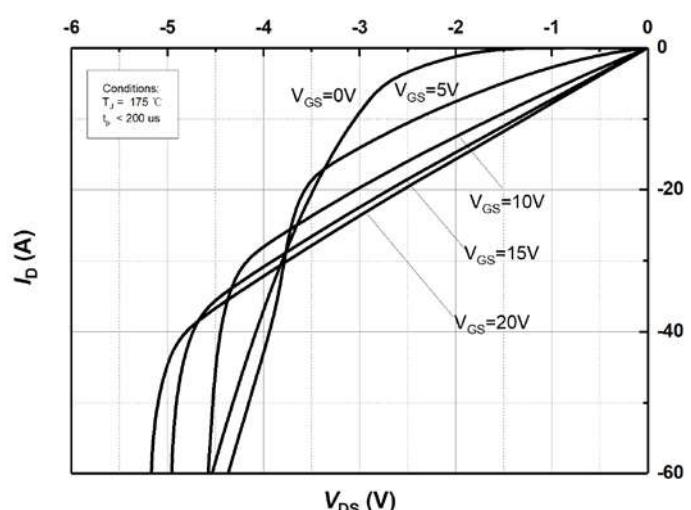


Figure 12. 3rd Quadrant Characteristic at $T_J=175^\circ\text{C}$



Typical Characteristics Diagrams

Figure 13. Capacitances vs. Drain-Source Voltage (0 – 1000V)

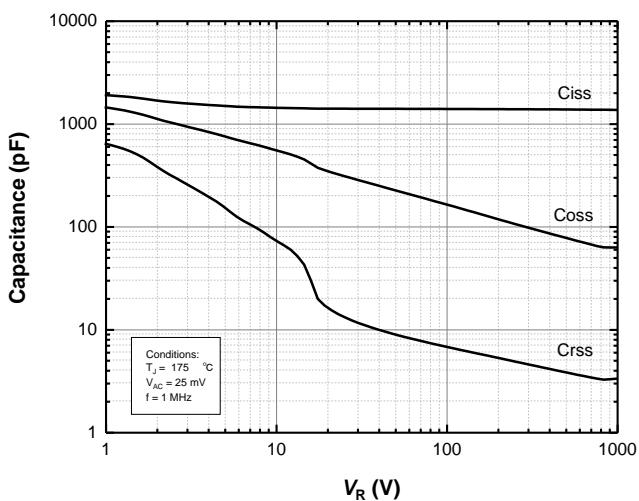


Figure 15. Transient Thermal Impedance (Junction – Case)

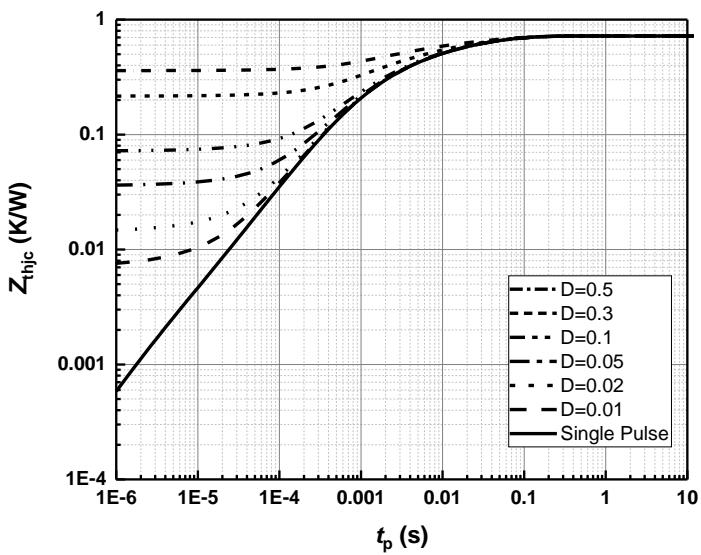


Figure 17. Output Capacitor Stored Energy

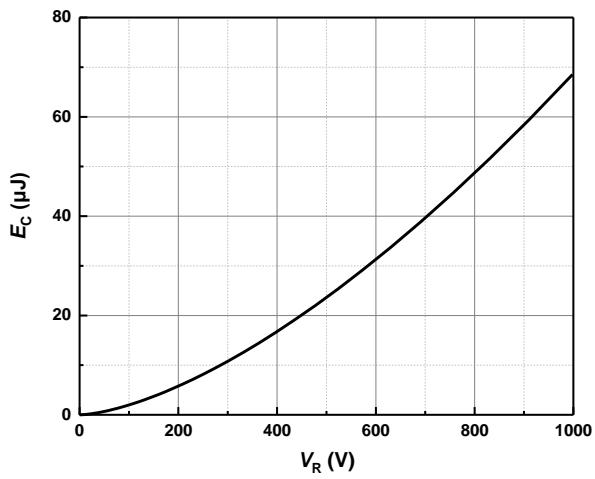


Figure 14. Continuous Drain Current Derating vs Case Temperature

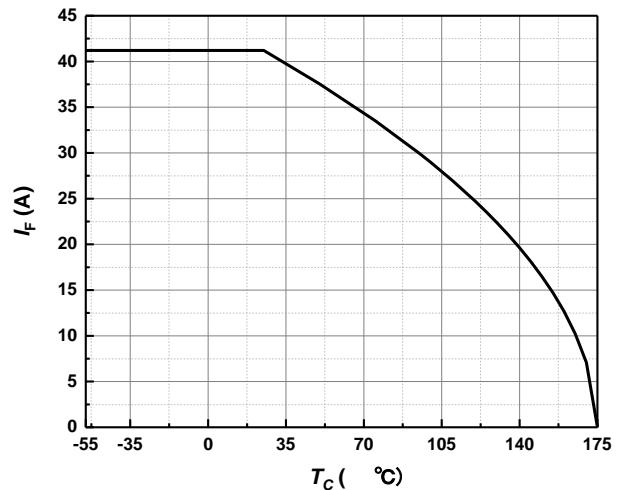


Figure 16. Maximum Power Dissipation Derating vs. Case Temperature

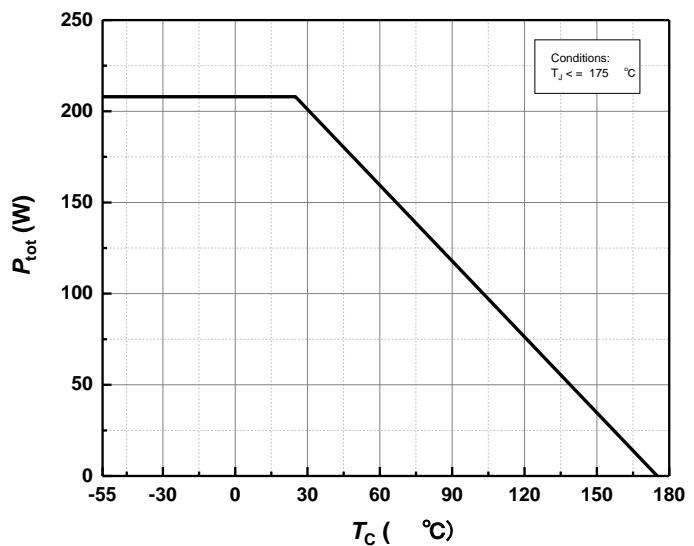
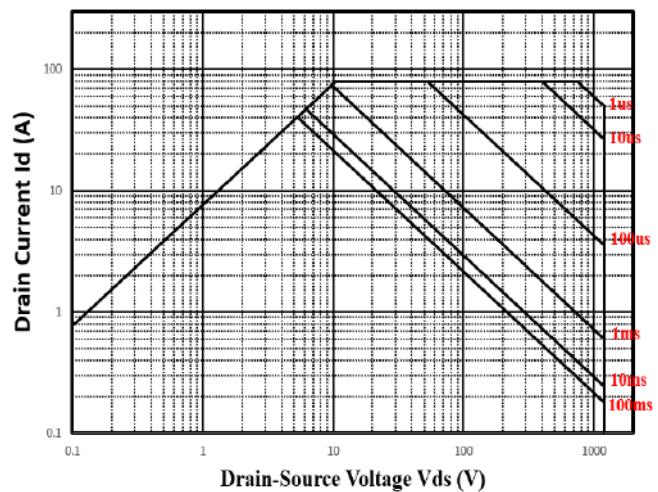


Figure 18. Safe Operating Area



Typical Characteristics Diagrams

Figure 19. Clamped Inductive Switching Energy vs. Drain Current($V_{DD} = 800V$)

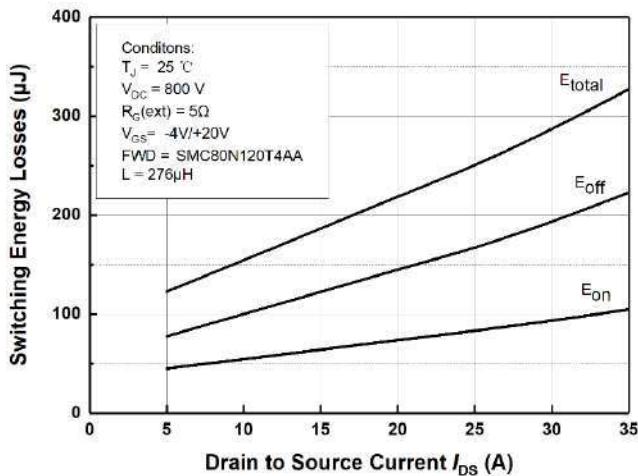


Figure 20. Clamped Inductive Switching Energy vs. Drain Current($V_{DD} = 600V$)

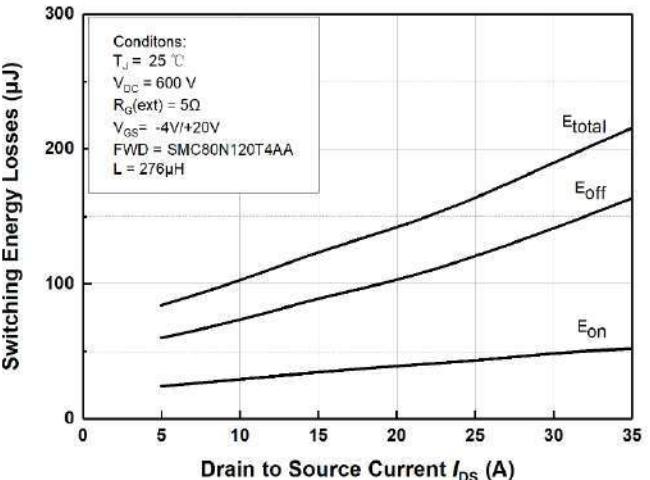


Figure 21. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

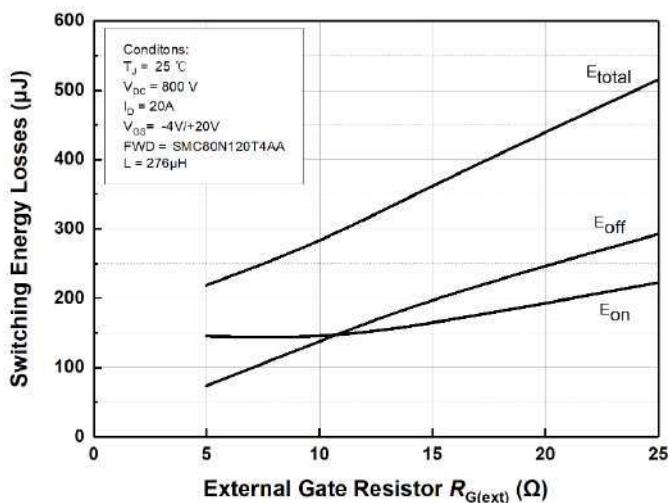
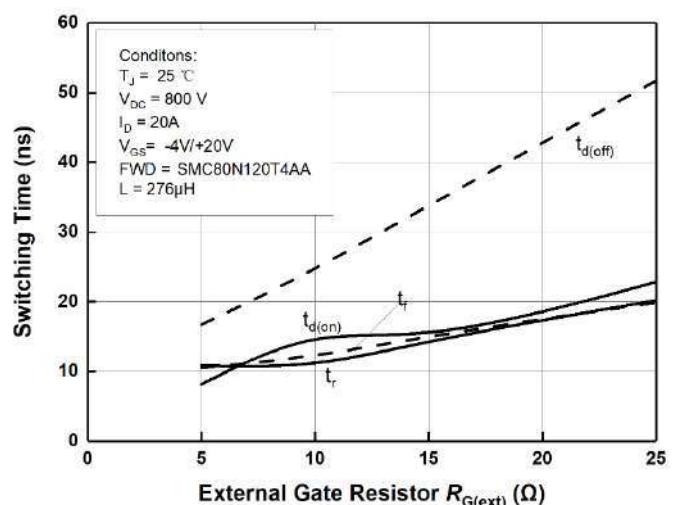


Figure 22. Switching Times vs. $R_{G(ext)}$



Dimensions

TO-247-4L package

